


<b>Search Notes</b> 	<b>Application/Control No.</b> 10517229	<b>Applicant(s)/Patent Under Reexamination</b> ICHIMURA ET AL.
	<b>Examiner</b> CHARLES KIM	<b>Art Unit</b> 2624

SEARCHED			
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SEARCH NOTES		
Search Notes	Date	Examiner
See East search history report	8/15/08	CK
IEEE Search	8/15/08	CK

INTERFERENCE SEARCH			
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